

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10568167	BECKER ET AL.
Examiner	Art Unit	
Liam J Heincer	1796	

SEARCHED

Class	Subclass	Date	Examiner
528	86	1/8/08	LH
528	4,8	5/26/2009	LJH

SEARCH NOTES

Search Notes	Date	Examiner
STIC STN Structure Search	1/8/08	LH
EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	1/14/08	LH
Inventor Name search	1/08/08	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	10/24/08	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	5/26/2009	LH
Updated EAST Search (USPAT, USPGPub, USOCR, EPO, JPO, DERWENT) see search report	12/29/2009	LH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
528	4,8	12/29/2009	LH